

<b>Notice of References Cited</b>	Application/Control No. 10/532,978	Applicant(s)/Patent Under Reexamination SANO ET AL.	
	Examiner Cedric A. Chan	Art Unit 1797	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,319,719	11-2001	Bhullar et al.	436/70
*	B	US-6,176,990	01-2001	Yager et al.	204/601
*	C	US-5,427,663	06-1995	Austin et al.	204/549
*	D	US-7,135,144	11-2006	Christel et al.	422/99
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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